

# Search Notes



Application/Control No.

10/708,015

Examiner

Jean W. Désir

Applicant(s)/Patent under Reexamination

SHAN ET AL.

Art Unit

2622

## SEARCHED

Class	Subclass	Date	Examiner
348	678	9/11/06	YMD
	673		
	686		
	687		
382	274		
	260		
updated		3/28/07	
search			
--	--	9/28/07	
358	327		
	532		

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
348	673	9/28/07	YMD
	687		
382	274		
358	532		

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST	9/11/06	
Interference	9/28/07	YMD
search		